









PCA9535 ZHCSNI9K - AUGUST 2005 - REVISED MARCH 2021

具有中断输出和配置寄存器的 PCA9535 远程 16 位 I2C 和 SMBus I/O 扩展器

1 特性

- 1μA 低待机电流消耗(最大值)
- I²C 至并行端口扩展器
- 开漏电路低电平有效中断输出
- 可耐受 5V 电压的 I/O 端口
- 兼容大多数微控制器
- 400kHz 快速 I²C 总线
- 针对多达 8 个器件使用的 3 个硬件地址引脚寻址
- 极性反转寄存器
- 具有高电流驱动能力的锁存输出,用于直接驱动
- 闩锁性能超过 100mA,符合 JESD 78 Ⅱ 类规范的 要求
- ESD 保护性能超过 JESD 22 规范要求
 - 2000V 人体放电模型 (A114-A)
 - 1000V 带电器件模型 (C101)

2 说明

这个用于两线双向总线 (I2C) 的 16 位扩展器设计用于 在 2.3V 至 5.5V VCC 之间运行。通过 I²C 接口 [串行 时钟 (SCL), 串行数据 (SDA)], 它为大多数微控制器 系列产品提供通用远程 I/O 扩展。

PCA9535 由两个 8 位配置(输入或输出可选)、输入 端口、输出端口和极性反转(高电平有效或低电平有效 运行)寄存器组成。在加电时,I/O 被配置为输入。系 统主控制器可以通过写入 I/O 配置位将 I/O 启用为输入 或输出。每个输入或输出的数据均保存在相应的输入或 输出端口寄存器中。输入端口寄存器的极性可借助极性 反转寄存器进行转换。所有寄存器都可由系统主控器读 取。

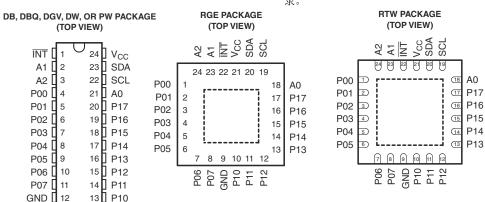
发生超时或其他不当操作时,系统主控器可通过使用上 电复位功能,将寄存器置于其默认状况并初始化 I2C/ SMBus 状态机来复位 PCA9535。

PCA9535 开漏中断 (INT) 输出在任意输入状态与其对 应的输入端口寄存器状态不同时被激活,并用于向系统 主控器指明输入状态已改变。

器件信息⁽¹⁾

器件型号	封装	封装尺寸(标称值)
PCA9535	SSOP (16)	6.20mm x 5.30mm
	VQFN (16)	4.00mm x 4.00mm
	四方扁平无引线 (QFN) (16)	3.00mm × 3.00mm

如需了解所有可用封装,请参阅数据表末尾的可订购产品附





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4 Description Continued

INT can be connected to the interrupt input of a microcontroller. By sending an interrupt signal on this line, the remote I/O can inform the microcontroller if there is incoming data on its ports without having to communicate via the I²C bus. Thus, the PCA9535 can remain a simple slave device.

The device outputs (latched) have high-current drive capability for directly driving LEDs. The device has low current consumption.

Although pin-to-pin and I²C address compatible with the PCF8575, software changes are required due to the enhancements.

The PCA9535 is identical to the PCA9555, except for the removal of the internal I/O pullup resistor, which greatly reduces power consumption when the I/Os are held low.

Three hardware pins (A0, A1, and A2) are used to program and vary the fixed I^2C address and allow up to eight devices to share the same I^2C bus or SMBus. The fixed I^2C address of the PCA9535 is the same as the PCA9555, PCF8575C, and PCF8574, allowing up to eight of these devices in any combination to share the same I^2C bus or SMBus.



5 Pin Configuration and Functions

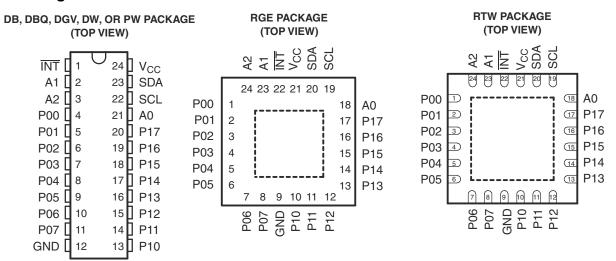


表 5-1. Pin Functions

	PIN		
NAME	SOIC (D), SSOP (DB), QSOP (DBQ), TSSOP (PW), AND TVSOP (DGV)	QFN (RGE AND RTW)	DESCRIPTION
INT	1	22	Interrupt output. Connect to V _{CC} through a pullup resistor.
A1	2	23	Address input. Connect directly to V _{CC} or ground.
A2	3	24	Address input. Connect directly to V _{CC} or ground.
P00	4	1	P-port input/output. Push-pull design structure.
P01	5	2	P-port input/output. Push-pull design structure.
P02	6	3	P-port input/output. Push-pull design structure.
P03	7	4	P-port input/output. Push-pull design structure.
P04	8	5	P-port input/output. Push-pull design structure.
P05	9	6	P-port input/output. Push-pull design structure.
P06	10	7	P-port input/output. Push-pull design structure.
P07	11	8	P-port input/output. Push-pull design structure.
GND	12	9	Ground
P10	13	10	P-port input/output. Push-pull design structure.
P11	14	11	P-port input/output. Push-pull design structure.
P12	15	12	P-port input/output. Push-pull design structure.
P13	16	13	P-port input/output. Push-pull design structure.
P14	17	14	P-port input/output. Push-pull design structure.
P15	18	15	P-port input/output. Push-pull design structure.
P16	19	16	P-port input/output. Push-pull design structure.
P17	20	17	P-port input/output. Push-pull design structure.
A0	21	18	Address input. Connect directly to V _{CC} or ground.
SCL	22	19	Serial clock bus. Connect to V _{CC} through a pullup resistor.
SDA	23	20	Serial data bus. Connect to V _{CC} through a pullup resistor.
V _{CC}	24	21	Supply voltage

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		·	MIN	MAX	UNIT
V _{CC}	Supply voltage range		- 0.5	6	V
VI	Input voltage range ⁽²⁾		- 0.5	6	V
Vo	Output voltage range ⁽²⁾		- 0.5	6	V
I _{IK}	Input clamp current	V ₁ < 0		- 20	mA
I _{OK}	Output clamp current	V _O < 0		- 20	mA
I _{IOK}	Input/output clamp current	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
I _{OL}	Continuous output low current	$V_{O} = 0$ to V_{CC}		50	mA
I _{OH}	Continuous output high current	$V_{O} = 0$ to V_{CC}		- 50	mA
	Continuous current through GND Continuous current through V _{CC}			- 250	mA
I _{CC}				160	IIIA
T _{stg}	Storage temperature range		- 65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			MIN	MAX	UNIT
V _(ESD) Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	0	2000	V	
V _(ESD)	Lieurostano discriarge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	0	1000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

			MIN	MAX	UNIT
V _{CC}	Supply voltage		2.3	V _{CC}	٧
V _{IH} High-level i	High level input voltage	SCL, SDA	0.7 × V _{CC}	V _{CC}	V
	High-level input voltage	A2 - A0, P07 - P00, P17 - P10	0.7 × V _{CC}	5.5	V
.,	Low-level input voltage	SCL, SDA	- 0.5	0.3 × V _{CC}	V
V _{IL}		A2 - A0, P07 - P00, P17 - P10	- 0.5	0.3 × V _{CC}	V
I _{OH}	High-level output current	P07 - P00, P17 - P10		- 10	mA
I _{OL}	Low-level output current	P07 - P00, P17 - P10		25	mA
T _A	Operating free-air temperature		- 40	85	°C

⁽²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.4 Thermal Resistance Characteristics

				204	0505			
				PCA	9535			
THERMAL ME	TRIC ⁽¹⁾	DB (SSOP)	DBQ (SSOP)	DVG (TVSOP)	DW (SOIC)	PW (TSSOP)	RGV (VQFN)	UNIT
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	°C/W
R _{θ JA}	Junction-to-ambient thermal resistance	92.9	61	86	108.8	48.4	43.6	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IK}	Input diode clamp voltage	I _I = -18 mA	2.3 V to 5.5 V	- 1.2			V
V _{PORR}	Power-on reset voltage, V _{CC} rising	$V_I = V_{CC}$ or GND, $I_O = 0$			1.2	1.65	V
V _{PORF}	Power-on reset voltage, V _{CC} falling	V _I = V _{CC} or GND, I _O = 0		0.75	1		V
			2.3 V	1.8			
		I _{OH} = -8 mA	3 V	2.6			
	P-port high-level output voltage ⁽²⁾		4.75 V	4.1			V
V _{OH}	P-port nign-level output voltage		2.3 V	1.7			v
		I _{OH} = -10 mA	3 V	2.5			
			4.75 V	4			
	SDA	V _{OL} = 0.4 V		3			
1	P port ⁽³⁾	V _{OL} = 0.5 V	2.3 V to 5.5 V	8	20		mA
I _{OL}		V _{OL} = 0.7 V	2.5 V to 5.5 V	10	24		
	INT	V _{OL} = 0.4 V		3			
ı.	SCL, SDA	V _I = V _{CC} or GND	2.3 V to 5.5 V			±1	μ Α
l _l	A2 - A0	AI - ACC OL GIAD	2.5 V to 5.5 V			±1	μА
I _{IH}	P port	V _I = V _{CC}	2.3 V to 5.5 V			1	μА
I _{IL}	P port	V _I = GND	2.3 V to 5.5 V			- 1	μА
		$V_I = V_{CC}$ or GND, $I_O = 0$, $I/O = inputs$, $f_{SCL} = 400 \text{ kHz}$	5.5 V		100	200	
	Operating mode		3.6 V		30	75	
			2.7 V		20	50	
I _{CC}			5.5 V		1.5	8.7	μ Α
	Standby mode	V_I = GND, I_O = 0, I/O = inputs, f_{SCL} = 0 kHz	3.6 V		0.9	4	
		ISCL - O KI IZ	2.7 V		0.6	3	
ΔI _{CC}	Additional current in standby mode	One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND	2.3 V to 5.5 V			200	μА
Cı	SCL	V _I = V _{CC} or GND	2.3 V to 5.5 V		3	8	pF
	SDA	V = V = CND	227/4- 5.57/		3	9.5	
C _{io}	P port	$V_{IO} = V_{CC}$ or GND	2.3 V to 5.5 V		3.7	9.5	pF

⁽¹⁾ All typical values are at nominal supply voltage (2.5-V, 3.3-V, or 5-V V_{CC}) and T_A = 25°C.

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⁽²⁾ Each I/O must be limited externally to a maximum of 25 mA, and each octal (P07 - P00 and P17 - P10) must be limited to a maximum current of 100 mA, for a device total of 200 mA.

⁽³⁾ The total current sourced by all I/Os must be limited to 160 mA (80 mA for P07 - P00 and 80 mA for P17 - P10).



6.6 I²C Interface Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see 🛭 7-1)

		, ,	MIN	MAX	UNIT
f _{scl}	I ² C clock frequency		0	400	kHz
t _{sch}	I ² C clock high time		0.6		μs
t _{scl}	I ² C clock low time		1.3		μ s
t _{sp}	I ² C spike time			50	ns
t _{sds}	I ² C serial-data setup time		100		ns
t _{sdh}	I ² C serial-data hold time		0		ns
t _{icr}	I ² C input rise time		20 + 0.1C _b ⁽¹⁾	300	ns
t _{icf}	I ² C input fall time		20 + 0.1C _b ⁽¹⁾	300	ns
t _{ocf}	I ² C output fall time	10-pF to 400-pF bus	20 + 0.1C _b (1)	300	ns
t _{buf}	I ² C bus free time between Stop and Start		1.3		μS
t _{sts}	I ² C Start or repeated Start condition setu	p	0.6		μS
t _{sth}	I ² C Start or repeated Start condition hold		0.6		μ s
t _{sps}	I ² C Stop condition setup		0.6		μ s
t _{vd(data)}	Valid-data time	SCL low to SDA output valid	50		ns
t _{vd(ack)}	Valid-data time of ACK condition	ACK signal from SCL low to SDA (out) low	0.1	0.9	μs
C _b	I ² C bus capacitive load	,		400	pF

⁽¹⁾ C_b = total capacitance of one bus line in pF

6.7 Switching Characteristics

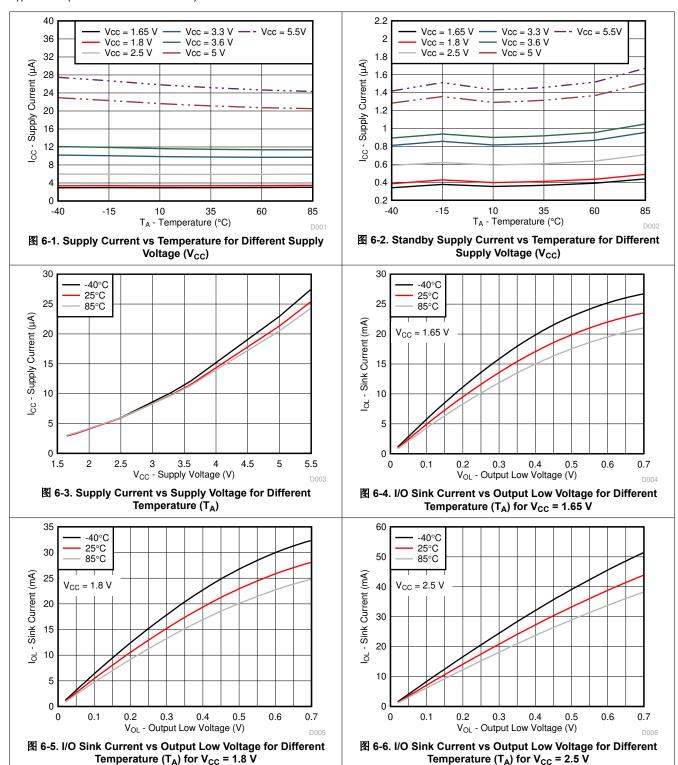
over recommended operating free-air temperature range, $C_L \le 100$ pF (unless otherwise noted) (see \boxtimes 7-2 and \boxtimes 7-3)

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
t _{iv}	Interrupt valid time	P port	ĪNT		4	μ S
t _{ir}	Interrupt reset delay time	SCL	ĪNT		4	μ S
t _{pv}	Output data valid	SCL	P port		200	ns
t _{ps}	Input data setup time	P port	SCL	150		ns
t _{ph}	Input data hold time	P port	SCL	1		μ S



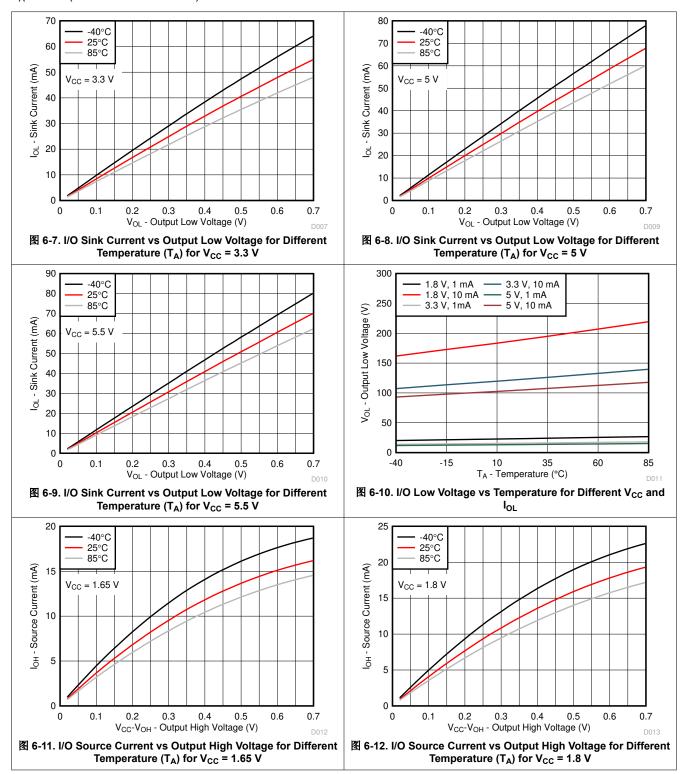
6.8 Typical Characteristics

T_A = 25°C (unless otherwise noted)



6.8 Typical Characteristics (continued)

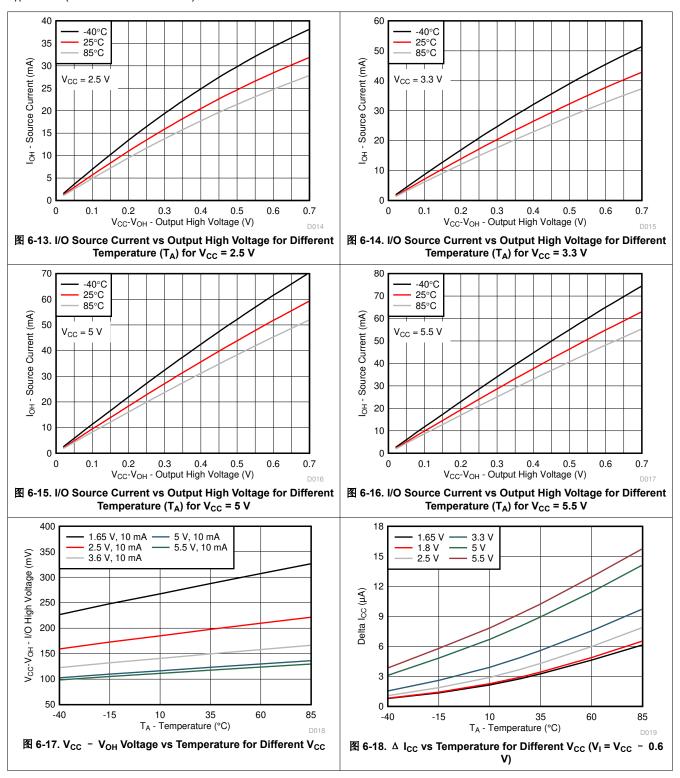
T_A = 25°C (unless otherwise noted)





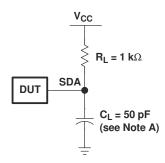
6.8 Typical Characteristics (continued)

T_A = 25°C (unless otherwise noted)

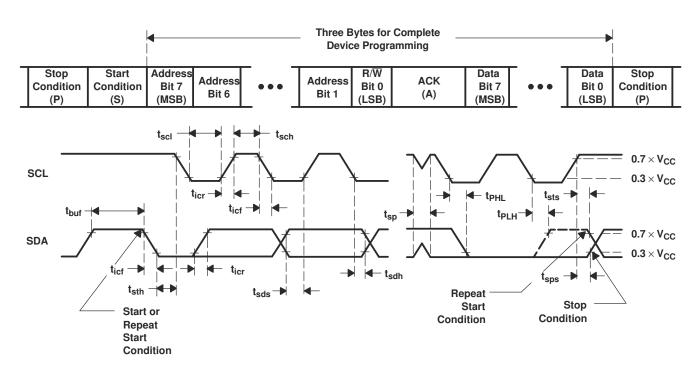




7 Parameter Measurement Information



SDA LOAD CONFIGURATION



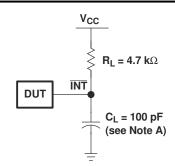
VOLTAGE WAVEFORMS

BYTE	DESCRIPTION
1	I ² C address
2, 3	P-port data

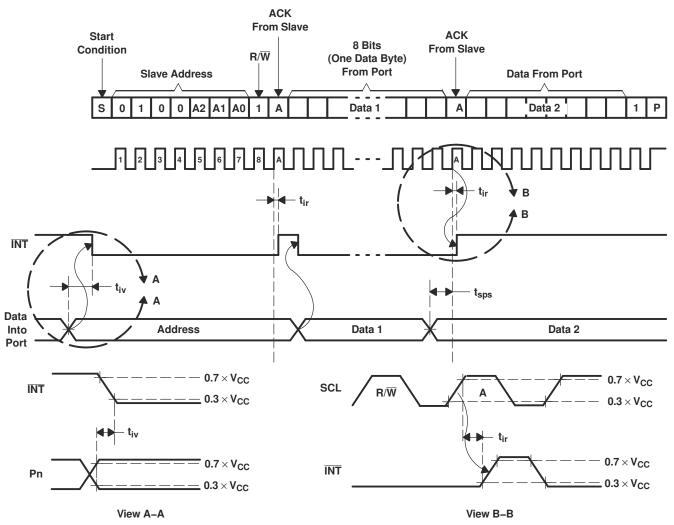
- A. C_L includes probe and jig capacitance.
- B. All inputs are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{O} = 50 Ω , $t_{f}/t_{f} \leq$ 30 ns.
- C. All parameters and waveforms are not applicable to all devices.

图 7-1. I²C Interface Load Circuit And Voltage Waveforms



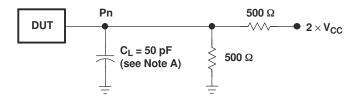


INTERRUPT LOAD CONFIGURATION

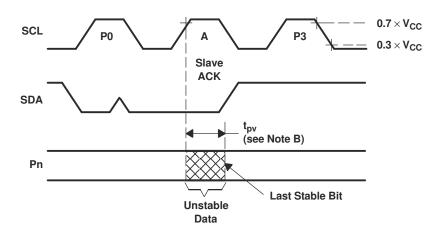


- A. C_L includes probe and jig capacitance.
- B. All inputs are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r/t_f \leq 30 ns.
- C. All parameters and waveforms are not applicable to all devices.

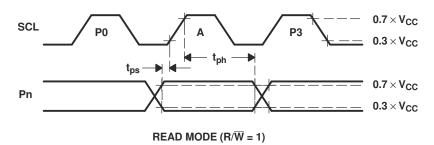
图 7-2. Interrupt Load Circuit And Voltage Waveforms



P-PORT LOAD CONFIGURATION



WRITE MODE $(R/\overline{W} = 0)$



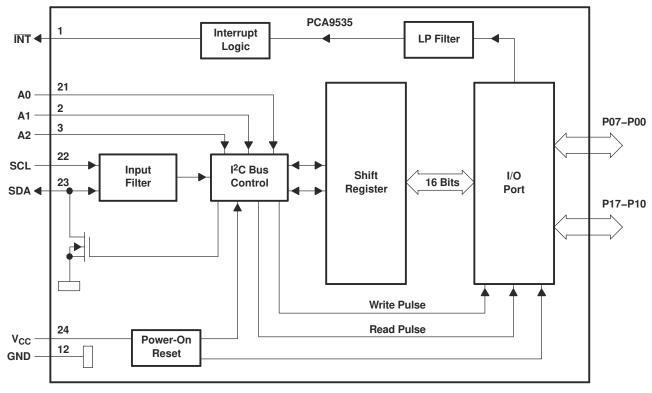
- A. C_L includes probe and jig capacitance.
- B. t_{pv} is measured from 0.7 × V_{CC} on SCL to 50% I/O (Pn) output.
- C. All inputs are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , $t_f/t_f \leq$ 30 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

图 7-3. P-Port Load Circuit And Voltage Waveforms



8 Detailed Description

8.1 Functional Block Diagram

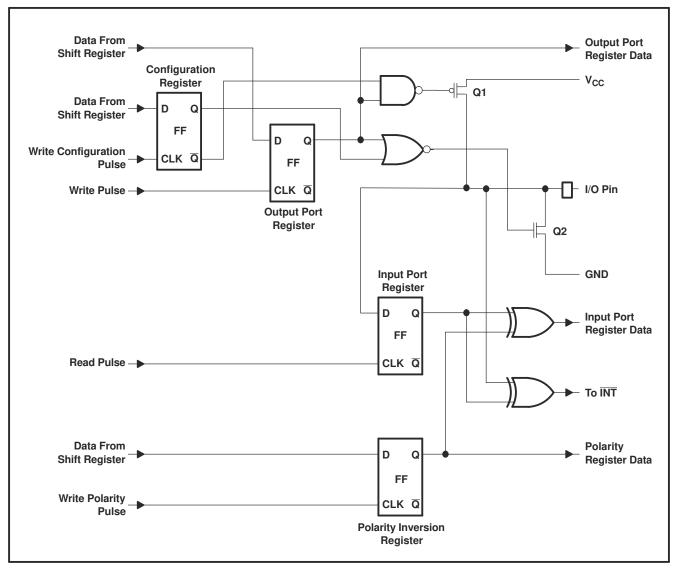


- A. Pin numbers shown are for DB, DBQ, DGV, DW, and PW packages.
- B. All I/Os are set to inputs at reset.

图 8-1. Logic Diagram (Positive Logic)

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A. At power-on reset, all registers return to default values.

图 8-2. Simplified Schematic Of P-Port I/Os

8.2 Device Functional Modes

8.2.1 Power-On Reset

When power (from 0 V) is applied to V_{CC} , an internal power-on reset holds the PCA9535 in a reset condition until V_{CC} has reached V_{POR} . At that point, the reset condition is released and the PCA9535 registers and $I^2C/SMBus$ state machine initialize to their default states. After that, V_{CC} must be lowered to below 0.2 V and then back up to the operating voltage for a power-reset cycle.

8.2.2 I/O Port

When an I/O is configured as an input, FETs Q1 and Q2 (in Simplified Schematic Of P-Port I/Os) are off, which creates a high-impedance input. The input voltage may be raised above V_{CC} to a maximum of 5.5 V.

If the I/O is configured as an output, Q1 or Q2 is enabled, depending on the state of the Output Port register. In this case, there are low-impedance paths between the I/O pin and either V_{CC} or GND. The external voltage applied to this I/O pin should not exceed the recommended levels for proper operation.

8.2.3 Interrupt (INT) Output

An interrupt is generated by any rising or falling edge of the port inputs in the input mode. After time, t_{iv} , the signal \overline{INT} is valid. Resetting the interrupt circuit is achieved when data on the port is changed to the original setting, data is read from the port that generated the interrupt. Resetting occurs in the read mode at the acknowledge (ACK) or not acknowledge (NACK) bit after the rising edge of the SCL signal.

Interrupts that occur during the ACK or NACK clock pulse can be lost (or be very short) due to the resetting of the interrupt during this pulse. Each change of the I/Os after resetting is detected and is transmitted as $\overline{\text{INT}}$. Writing to another device does not affect the interrupt circuit, and a pin configured as an output cannot cause an interrupt. Changing an I/O from an output to an input may cause a false interrupt to occur, if the state of the pin does not match the contents of the Input Port register. Because each 8-pin port is read independently, the interrupt caused by port 0 is not cleared by a read of port 1 or vice versa.

The INT output has an open-drain structure and requires pullup resistor to V_{CC}.

8.2.3.1 Interrupt Errata

Description

The INT will be improperly de-asserted if the following two conditions occur:

1. The last I²C command byte (register pointer) written to the device was 00h.

Note

This generally means the last operation with the device was a Read of the input register. However, the command byte may have been written with 00h without ever going on to read the input register. After reading from the device, if no other command byte written, it will remain 00h.

2. Any other slave device on the I²C bus acknowledges an address byte with the R/W bit set high

System Impact

Can cause improper interrupt handling as the Master will see the interrupt as being cleared.

System Workaround

Minor software change: User must change command byte to something besides 00h after a Read operation to the PCA9535 device or before reading from another slave device.

Note

Software change will be compatible with other versions (competition and TI redesigns) of this device.

8.3 Programming

8.3.1 I²C Interface

The bidirectional I²C bus consists of the serial clock (SCL) and serial data (SDA) lines. Both lines must be connected to a positive supply via a pullup resistor when connected to the output stages of a device. Data transfer may be initiated only when the bus is not busy.

 I^2C communication with this device is initiated by a master sending a Start condition, a high-to-low transition on the SDA input/output while the SCL input is high (see 8.3). After the Start condition, the device address byte is sent, MSB first, including the data direction bit (R/W). This device does not respond to the general call address.

After receiving the valid address byte, this device responds with an ACK, a low on the SDA input/output during the high of the ACK-related clock pulse. The address inputs (A0 - A2) of the slave device must not be changed between the Start and Stop conditions.

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On the I²C bus, only one data bit is transferred during each clock pulse. The data on the SDA line must remain stable during the high pulse of the clock period, as changes in the data line at this time are interpreted as control commands (Start or Stop) (see 8-4).

A Stop condition, a low-to-high transition on the SDA input/output while the SCL input is high, is sent by the master (see 8-3).

Any number of data bytes can be transferred from the transmitter to the receiver between the Start and the Stop conditions. Each byte of eight bits is followed by one ACK bit. The transmitter must release the SDA line before the receiver can send an ACK bit. The device that acknowledges must pull down the SDA line during the ACK clock pulse so that the SDA line is stable low during the high pulse of the ACK-related clock period (see 8-5). When a slave receiver is addressed, it must generate an ACK after each byte is received. Similarly, the master must generate an ACK after each byte that it receives from the slave transmitter. Setup and hold times must be met to ensure proper operation.

A master receiver signals an end of data to the slave transmitter by not generating an acknowledge (NACK) after the last byte has been clocked out of the slave. This is done by the master receiver by holding the SDA line high. In this event, the transmitter must release the data line to enable the master to generate a Stop condition.

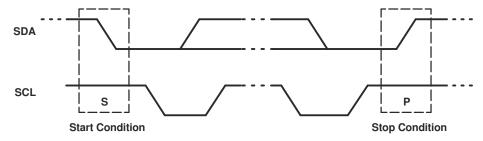


图 8-3. Definition Of Start And Stop Conditions

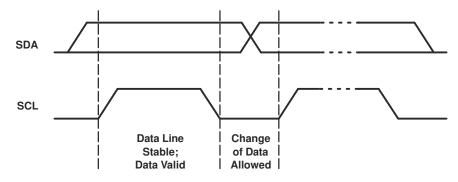


图 8-4. Bit Transfer



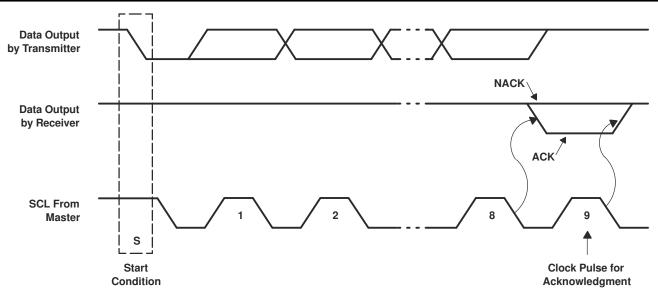


图 8-5. Acknowledgment On I²C Bus

8.3.2 Register Map

表 8-1. Interface Definition

ВҮТЕ	BIT										
	7 (MSB)	6	5	4	3	2	1	0 (LSB)			
I ² C slave address	L	Н	L	L	A2	A1	A0	R/W			
P0x I/O data bus	P07	P06	P05	P04	P03	P02	P01	P00			
P1x I/O data bus	P17	P16	P15	P14	P13	P12	P11	P10			

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8.3.2.1 Device Address

图 8-6 shows the address byte of the PCA9535.

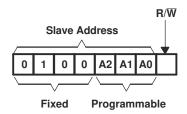


图 8-6. Pca9535 Address

表 8-2. Address Reference

	INPUTS		I ² C BUS SLAVE ADDRESS
A2	A1	A0	T C BUS SLAVE ADDRESS
L	L	L	32 (decimal), 20 (hexadecimal)
L	L	Н	33 (decimal), 21 (hexadecimal)
L	Н	L	34 (decimal), 22 (hexadecimal)
L	Н	Н	35 (decimal), 23 (hexadecimal)
Н	L	L	36 (decimal), 24 (hexadecimal)
Н	L	Н	37 (decimal), 25 (hexadecimal)
Н	Н	L	38 (decimal), 26 (hexadecimal)
Н	Н	Н	39 (decimal), 27 (hexadecimal)

The last bit of the slave address defines the operation (read or write) to be performed. A high (1) selects a read operation, while a low (0) selects a write operation.

8.3.2.2 Control Register And Command Byte

Following the successful acknowledgment of the address byte, the bus master sends a command byte that is stored in the control register in the PCA9535. Three bits of this data byte state the operation (read or write) and the internal register (Input, Output, Polarity Inversion, or Configuration) that will be affected. This register can be written or read through the I²C bus. The command byte is sent only during a write transmission.

Once a command byte has been sent, the register that was addressed continues to be accessed by reads until a new command byte has been sent.

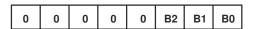


图 8-7. Control Register Bits

表 8-3. Control Register

CONTR	OL REGISTE	R BITS	COMMAND	REGISTER	PROTOCOL	POWER-UP
B2	B1	В0	BYTE (HEX)	REGISTER	PROTOCOL	DEFAULT
0	0	0	0x00	Input Port 0	Read byte	xxxx xxxx
0	0	1	0x01	Input Port 1	Read byte	XXXX XXXX
0	1	0	0x02	Output Port 0	Read/write byte	1111 1111
0	1	1	0x03	Output Port 1	Read/write byte	1111 1111
1	0	0	0x04	Polarity Inversion Port 0	Read/write byte	0000 0000
1	0	1	0x05	Polarity Inversion Port 1	Read/write byte	0000 0000
1	1	0	0x06	Configuration Port 0	Read/write byte	1111 1111
1	1	1	0x07	Configuration Port 1	Read/write byte	1111 1111

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8.3.2.3 Register Descriptions

The Input Port registers (registers 0 and 1) reflect the incoming logic levels of the pins, regardless of whether the pin is defined as an input or an output by the Configuration Register. It only acts on read operation. Writes to these registers have no effect. The default value, X, is determined by the externally applied logic level.

Before a read operation, a write transmission is sent with the command byte to let the I²C device know that the Input Port registers will be accessed next.

Bit	10.7	10.6	10.5	10.4	10.3	10.2	10.1	10.0
Default	Х	Х	Х	Х	Х	Х	Х	Х
Bit	I1.7	I1.6	I1.5	I1.4	I1.3	I1.2	I1.1	I1.0
Default	Х	Х	Х	Х	Х	Х	Х	Х

The Output Port registers (registers 2 and 3) show the outgoing logic levels of the pins defined as outputs by the Configuration register. Bit values in this register have no effect on pins defined as inputs. In turn, reads from this register reflect the value that is in the flip-flop controlling the output selection, not the actual pin value.

表 8-5. Registers 2 And 3 (Output Port Registers)

Bit	O0.7	O0.6	O0.5	O0.4	O0.3	O0.2	O0.1	O0.0
Default	1	1	1	1	1	1	1	1
Bit	01.7	O1.6	O1.5	01.4	01.3	01.2	01.1	O1.0
Default	1	1	1	1	1	1	1	1

The Polarity Inversion registers (registers 4 and 5) allow polarity inversion of pins defined as inputs by the Configuration register. If a bit in this register is set (written with 1), the corresponding pin's polarity is inverted. If a bit in this register is cleared (written with a 0), the corresponding pin's original polarity is retained.

表 8-6. Registers 4 And 5 (Polarity Inversion Registers)

Bit	N0.7	N0.6	N0.5	N0.4	N0.3	N0.2	N0.1	N0.0
Default	0	0	0	0	0	0	0	0
Bit	N1.7	N1.6	N1.5	N1.4	N1.3	N1.2	N1.1	N1.0
Default	0	0	0	0	0	0	0	0

The Configuration registers (registers 6 and 7) configure the directions of the I/O pins. If a bit in this register is set to 1, the corresponding port pin is enabled as an input with a high-impedance output driver. If a bit in this register is cleared to 0, the corresponding port pin is enabled as an output.

表 8-7. Registers 6 And 7 (Configuration Registers)

	• -	•		•	-	•	,	
Bit	C0.7	C0.6	C0.5	C0.4	C0.3	C0.2	C0.1	C0.0
Default	1	1	1	1	1	1	1	1
Bit	C1.7	C1.6	C1.5	C1.4	C1.3	C1.2	C1.1	C1.0
Default	1	1	1	1	1	1	1	1

8.3.2.4 Bus Transactions

Data is exchanged between the master and the PCA9535 through write and read commands.

8.3.2.4.1 Writes

Data is transmitted to the PCA9535 by sending the device address and setting the least-significant bit to a logic 0 (see 🖺 8-6 for device address). The command byte is sent after the address and determines which register receives the data that follows the command byte.

The eight registers within the PCA9535 are configured to operate as four register pairs. The four pairs are Input Ports, Output Ports, Polarity Inversions, and Configurations. After sending data to one register, the next data byte is sent to the other register in the pair (see 8 8-8 and 8 8-9). For example, if the first byte is sent to Output Port 1 (register 3), the next byte is stored in Output Port 0 (register 2).

There is no limitation on the number of data bytes sent in one write transmission. In this way, each 8-bit register may be updated independently of the other registers.

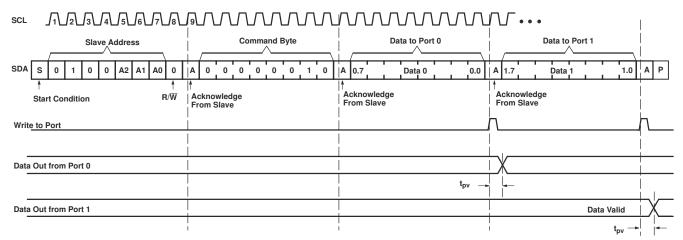


图 8-8. Write To Output Port Registers

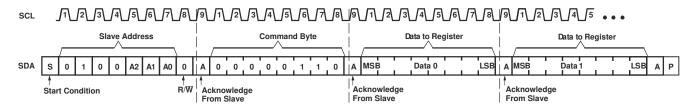


图 8-9. Write To Configuration Registers

8.3.2.4.2 Reads

The bus master first must send the PCA9535 address with the least-significant bit set to a logic 0 (see 图 8-6 for device address). The command byte is sent after the address and determines which register is accessed. After a restart, the device address is sent again, but this time, the least-significant bit is set to a logic 1. Data from the register defined by the command byte then is sent by the PCA9535 (see 图 8-10 through 图 8-12).

After a restart, the value of the register defined by the command byte matches the register being accessed when the restart occurred. For example, if the command byte references Input Port 1 before the restart, and the restart occurs when Input Port 0 is being read, the stored command byte changes to reference Input Port 0. The original command byte is forgotten. If a subsequent restart occurs, Input Port 0 is read first. Data is clocked into the register on the rising edge of the ACK clock pulse. After the first byte is read, additional bytes may be read, but the data now reflect the information in the other register in the pair. For example, if Input Port 1 is read, the next byte read is Input Port 0.

Data is clocked into the register on the rising edge of the ACK clock pulse. There is no limitation on the number of data bytes received in one read transmission, but when the final byte is received, the bus master must not acknowledge the data

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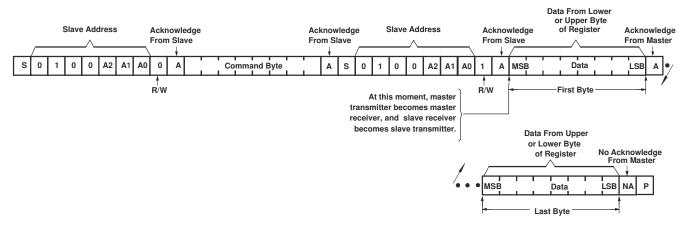
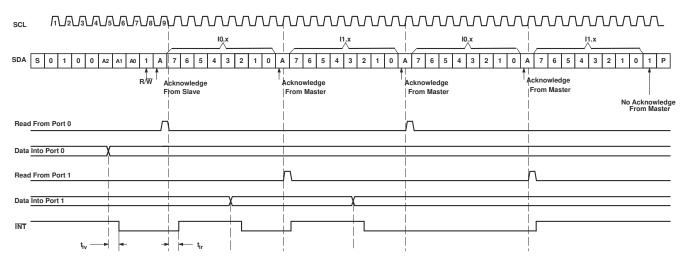


图 8-10. Read From Register

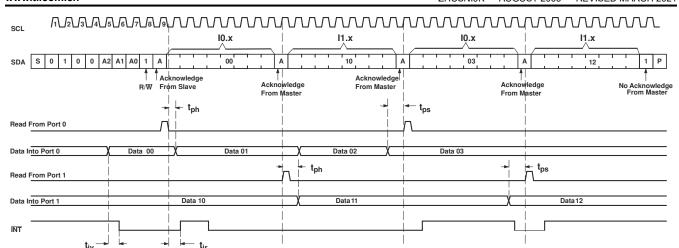


- A. Transfer of data can be stopped at any time by a Stop condition. When this occurs, data present at the latest acknowledge phase is valid (output mode). It is assumed that the command byte previously has been set to 00 (read Input Port register).
- B. This figure eliminates the command byte transfer, a restart, and slave address call between the initial slave address call and actual data transfer from P port (see 🖺 8-10 for these details).

图 8-11. Read Input Port Register, Scenario 1

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- A. Transfer of data can be stopped at any time by a Stop condition. When this occurs, data present at the latest acknowledge phase is valid (output mode). It is assumed that the command byte previously has been set to 00 (read Input Port register).
- B. This figure eliminates the command byte transfer, a restart, and slave address call between the initial slave address call and actual data transfer from P port (see 🛭 8-10 for these details).

图 8-12. Read Input Port Register, Scenario 2



9 Application Information Disclaimer

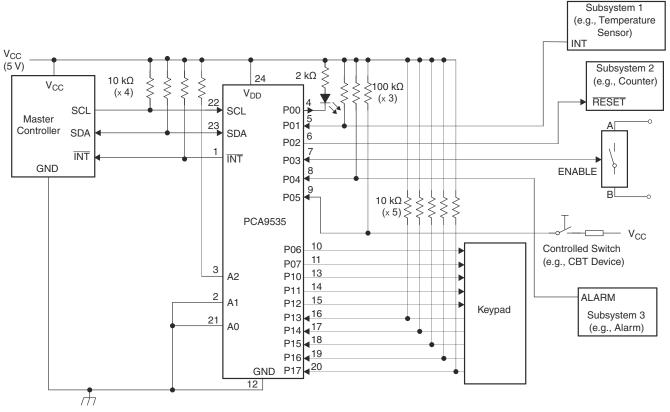
Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

9.2 Typical Application

8 9-1 shows an application in which the PCA9535 can be used.



- A. Device address is configured as 0100100 for this example.
- B. P00, P02, and P03 are configured as outputs.
- C. P01, P04 P07, and P10 P17 are configured as inputs.
- D. Pin numbers shown are for DB, DBQ, DGV, DW, and PW packages.

图 9-1. Typical Application

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9.2.1 Design Requirements

9.2.1.1 Minimizing I_{CC} When I/O Is Used To Control Led

When an I/O is used to control an LED, normally it is connected to V_{CC} through a resistor as shown in \boxtimes 9-3. Because the LED acts as a diode, when the LED is off, the I/O V_{IN} is about 1.2 V less than V_{CC} . The \triangle I_{CC} parameter in Electrical Characteristics shows how I_{CC} increases as V_{IN} becomes lower than V_{CC} . For battery-powered applications, it is essential that the voltage of I/O pins is greater than or equal to V_{CC} , when the LED is off, to minimize current consumption.

 \boxtimes 9-2 shows a high-value resistor in parallel with the LED. \boxtimes 9-3 shows V_{CC} less than the LED supply voltage by at least 1.2 V. Both of these methods maintain the I/O V_{IN} at or above V_{CC} and prevent additional supply-current consumption when the LED is off.

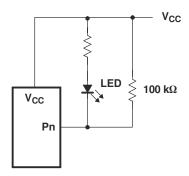


图 9-2. High-Value Resistor In Parallel With Led

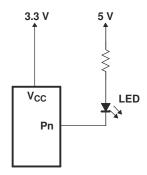


图 9-3. Device Supplied By Lower Voltage



10 Power Supply Recommendations

10.1 Power-On Reset Requirements

In the event of a glitch or data corruption, PCA9535 can be reset to its default conditions by using the power-on reset feature. Power-on reset requires that the device go through a power cycle to be completely reset. This reset also happens when the device is powered on for the first time in an application.

The two types of power-on reset are shown in \boxtimes 10-1 and \boxtimes 10-2.

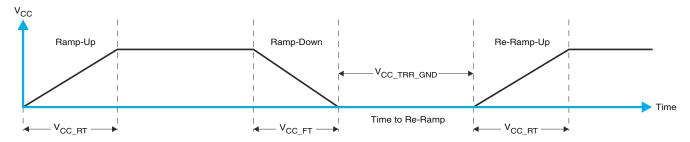


图 10-1. V_{CC} Is Lowered Below 0.2 V Or 0 V And Then Ramped Up To V_{CC}

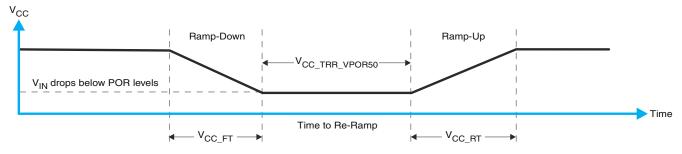


图 10-2. V_{CC} is Lowered Below The Por Threshold, Then Ramped Back Up To V_{CC}

表 10-1 specifies the performance of the power-on reset feature for PCA9535 for both types of power-on reset.

	PARAMETER		MIN	TYP	MAX	UNIT
V _{CC_FT}	Fall rate	See 图 10-1	1		100	ms
V _{CC_RT}	Rise rate	See 图 10-1	0.01		100	ms
V _{CC_TRR_GND}	Time to re-ramp (when V _{CC} drops to GND)	See 图 10-1	0.001			ms
V _{CC_TRR_POR50}	Time to re-ramp (when V _{CC} drops to V _{POR_MIN} - 50 mV)	See 图 10-2	0.001			ms
V _{CC_GH}	Level that V_{CCP} can glitch down to, but not cause a functional disruption when V_{CCX_GW} = 1 $~\mu$ s	See 图 10-3			1.2	V
V _{CC_GW}	Glitch width that will not cause a functional disruption when $V_{CCX_GH} = 0.5 \times V_{CCx}$	See 图 10-3				μS
V _{PORF}	Voltage trip point of POR on falling V _{CC}		0.767		1.144	V
V _{PORR}	Voltage trip point of POR on rising V _{CC}		1.033		1.428	V

表 10-1. Recommended Supply Seguencing And Ramp Rates⁽¹⁾

(1) $T_A = -40^{\circ}C$ to 85°C (unless otherwise noted)

Glitches in the power supply can also affect the power-on reset performance of this device. The glitch width (V_{CC GW}) and height (V_{CC GH}) are dependent on each other. The bypass capacitance, source impedance, and the device impedance are factors that affect power-on reset performance. 图 10-3 and 表 10-1 provide more information on how to measure these specifications.

Product Folder Links: PCA9535

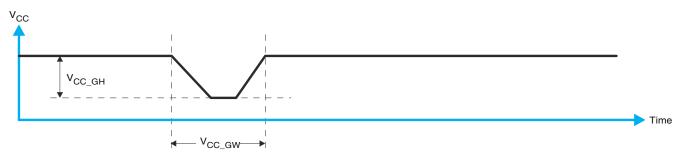
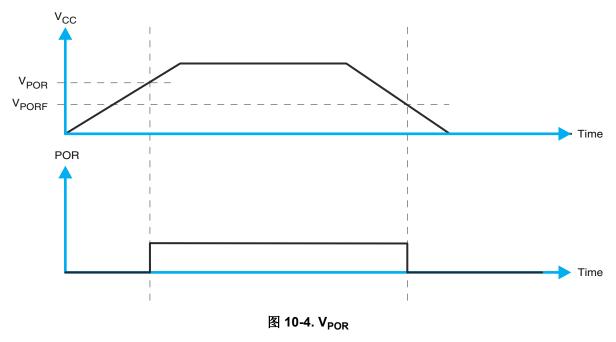


图 10-3. Glitch Width And Glitch Height

 V_{POR} is critical to the power-on reset. V_{POR} is the voltage level at which the reset condition is released and all the registers and the I²C/SMBus state machine are initialized to their default states. The value of V_{POR} differs based on the V_{CC} being lowered to or from 0. \boxtimes 10-4 and \gtrapprox 10-1 provide more details on this specification.





11 Device and Documentation Support

11.1 Receiving Notification of Documentation Updates

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: PCA9535

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27-Jun-2025

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
PCA9535DB	Obsolete	Production	SSOP (DB) 24	-	-	Call TI	Call TI	-40 to 85	PD9535
PCA9535DBQR	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PCA9535
PCA9535DBQR.A	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PCA9535
PCA9535DGVR	Active	Production	TVSOP (DGV) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535DGVR.A	Active	Production	TVSOP (DGV) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535DW	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCA9535
PCA9535DW.A	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCA9535
PCA9535DWR	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCA9535
PCA9535DWR.A	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCA9535
PCA9535PWR	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535PWR.A	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535PWR.B	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535PWRG4	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535PWRG4.A	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535PWRG4.B	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RGER	Active	Production	VQFN (RGE) 24	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RGER.A	Active	Production	VQFN (RGE) 24	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RGER.B	Active	Production	VQFN (RGE) 24	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RGERG4	Active	Production	VQFN (RGE) 24	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RGERG4.A	Active	Production	VQFN (RGE) 24	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RGERG4.B	Active	Production	VQFN (RGE) 24	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD9535
PCA9535RTWR	Active	Production	WQFN (RTW) 24	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PD535
PCA9535RTWR.A	Active	Production	WQFN (RTW) 24	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PD535

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.



PACKAGE OPTION ADDENDUM

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- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION





	-
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PCA9535DBQR	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
PCA9535DGVR	TVSOP	DGV	24	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
PCA9535DWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
PCA9535RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
PCA9535RGERG4	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
PCA9535RTWR	WQFN	RTW	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2



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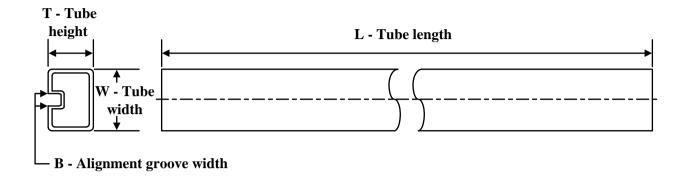
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins SPQ		Length (mm)	Width (mm)	Height (mm)
PCA9535DBQR	SSOP	DBQ	24	2500	353.0	353.0	32.0
PCA9535DGVR	TVSOP	DGV	24	2000	353.0	353.0	32.0
PCA9535DWR	SOIC	DW	24	2000	350.0	350.0	43.0
PCA9535RGER	VQFN	RGE	24	3000	346.0	346.0	33.0
PCA9535RGERG4	VQFN	RGE	24	3000	346.0	346.0	33.0
PCA9535RTWR	WQFN	RTW	24	3000	353.0	353.0	32.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
PCA9535DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
PCA9535DW.A	DW	SOIC	24	25	506.98	12.7	4826	6.6

DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.





SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE

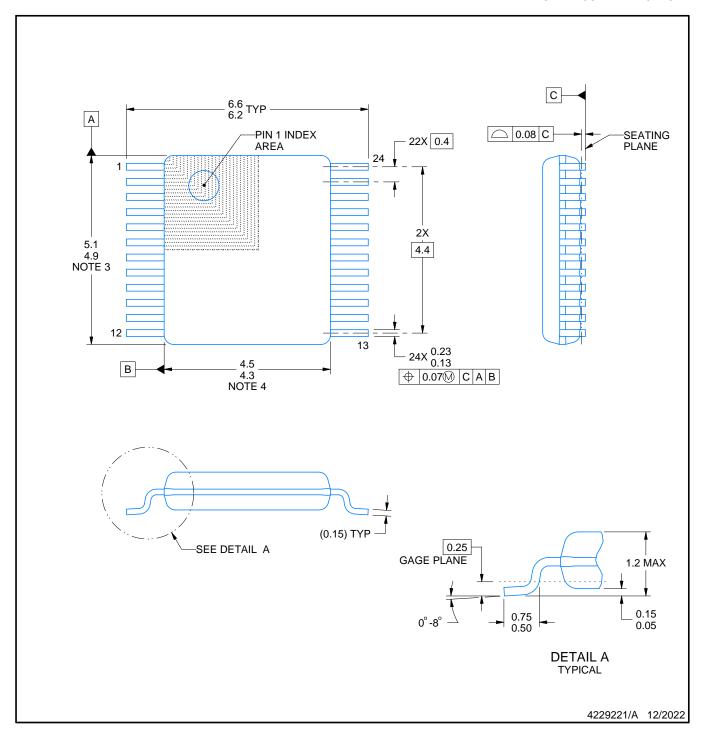


NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.







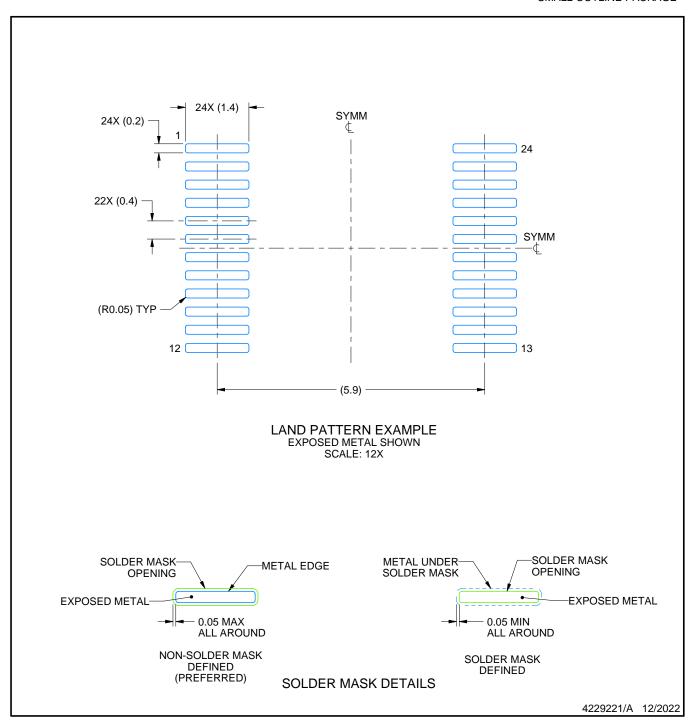
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



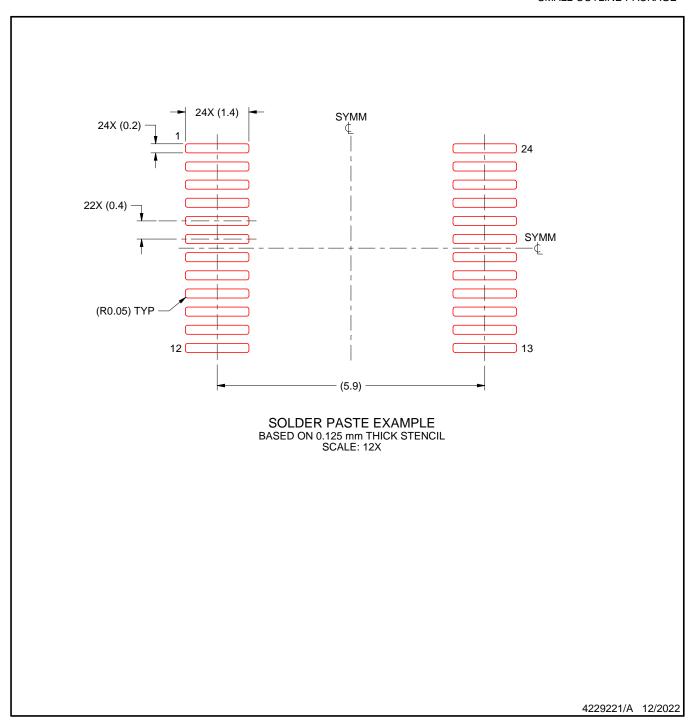


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



4 x 4, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





NOTES:

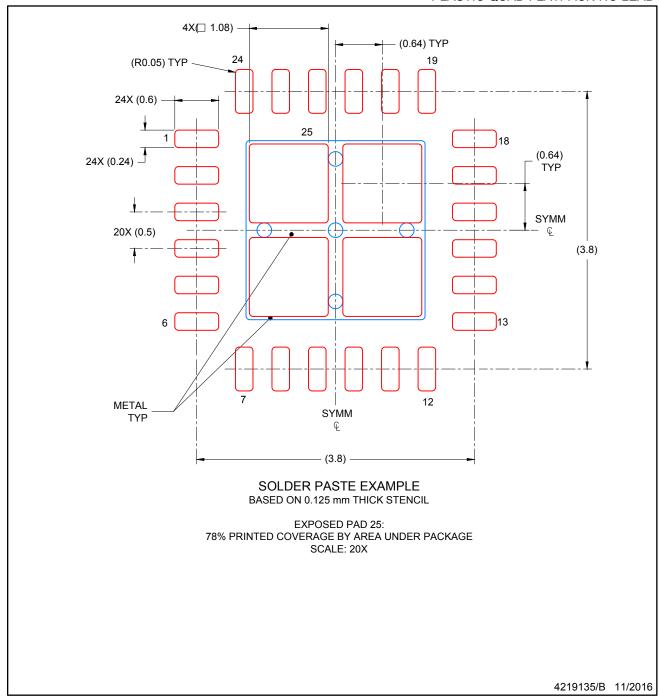
- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.





NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

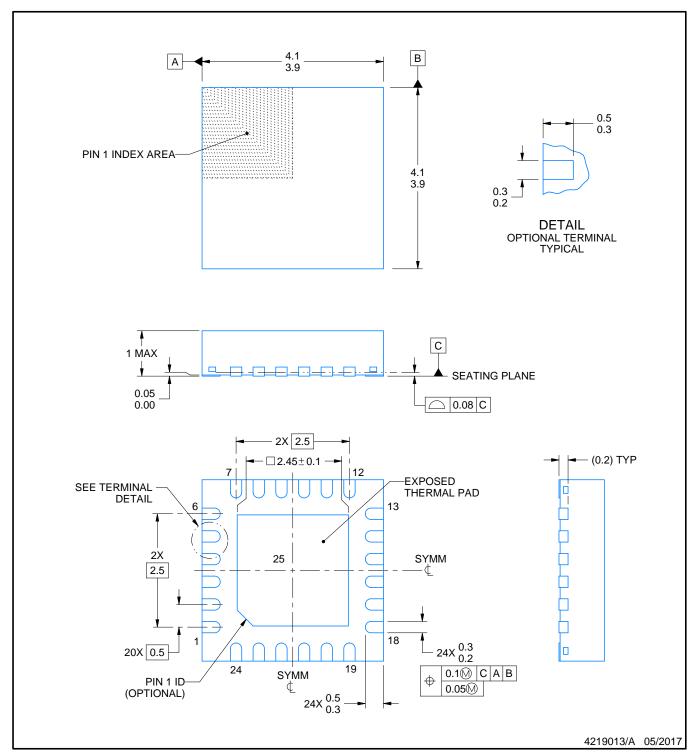


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4204104/H







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.





NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.





NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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